<u>TouchNetix</u>

1 Introduction

The aXiom AX198A-3D is a Capacitive Multi-touch controller with the very highest performance, for use in demanding applications across markets such as Automotive, Industrial, White Goods and Medical.

In addition to supporting state-of-the-art Capacitive Touch Sensing, the device also features integrated pressScreen force sensing and Haptic feedback output event triggers, to allow creation of rich user interfaces. Use of these features allows the device to sense not only conventional contact type touches, but also to detect the force applied to the touch sensor cover lens.

The high performance acquisition engine enables the touchscreen controller to sense regular contacts and gloves, as well as detecting pre-contact proximity and hover finger targets above the touchscreen surface. Additionally, the same sensing performance allows designers to use thick plastic front lenses, curved or non-uniform thickness lenses and even to sense through a small air gap. Industry leading water rejection and wet finger tracking is also included.

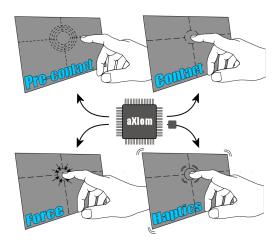


Figure 1-1: aXiom 3D Sensing Capabilities

Combined with the ability to output region based Haptic feedback commands to a 3rd party driver, the device becomes the central controller for a holistic user interface system, implementing 3D proximity, 3D hover, 3D overlays/lenses, touch, press and haptic feedback.

A Windows[™] based software package, TouchHub, is provided with the AX198A-3D to ease design and tuning tasks. This allows the designer to input simplified design choices and enables TouchHub to automatically create optimized tuning configurations. Additionally, a digitizer driver is available for Linux.

Features at a glance

Capacitive Multi-touch controller

- Ultra high SNR: >80dB
- Supports up to 198 touch sensing channels and a maximum of 6144 sensing nodes¹
- Flexible channel routing allows arbitrary touch sensor aspect ratios
- Supports large ultra-wide aspect ratio sensors (over 5:1)
- Concurrently supports 2D (xy), 1D (slider) and 0D (button) sensors
- Touch sensing through very thick plastic lenses and/or air gaps
- Supports non-uniform lens thickness
- Supports both 3D proximity and 3D hover sensing
- Supports up to 2 Dial On Display mechanical rotors
- \bullet All touches reported at a frame rate of up to 250Hz^2
- Glove support without switching modes
- Water suppression and wet finger tracking
- Low emissions, low drive amplitude, high immunity to conducted interference
- Host connection using SPI or I2C slave with interrupt
- 3V3 and 1V8 supply, no high voltage generators needed
- Independent I/O voltage supporting 1.8V to 3.3V host signaling
- Optional external synchronization with display drivers for highest SNR

pressScreen Force controller

- Supports up to 4 press sensing channels
- Can detect displacement of cover lens <10um
- Supports multi-press
- Force measured concurrently with touch

Haptic Trigger

- User definable region based haptics
- Configurable hot-spot maps and actions
- Trigger uses master I2C or GPIO output to 3rd party driver chip

General

- Register based tuning with non-volatile configuration storage
- Field upgradable firmware
- Sophisticated Built-In-Self-Test routines and diagnostics
- Automotive AEC-Q100 grade 2 qualified³
- -40° C to $+105^{\circ}$ C ambient operating temperature
- Available in LQFP256 package
- TouchHub evaluation and support software for design and tuning

¹Example: largest **square** sensor is 78x78 channels ²Subject to configuration

³Pending

2 Ordering Information

Device	Package	Order Code	Shipping	FW Revision
AX198A-3D	LQFP256	AX198A-3D -E-	36 devices per	wx.yz
LQFP256	Exposed Pad	LQFP256-EP28281404-B-V0 Rwxyz	tray	
Engineering	28x28x1.4x0.4			
Samples				
AX198A-3D	LQFP256	Contact TouchNetix for	36 devices per	
LQFP256	Exposed Pad	availability	tray	
Industrial	28x28x1.4x0.4			
AX198A-3D	LQFP256	Contact TouchNetix for	36 devices per	
LQFP256	Exposed Pad	availability	tray	
Automotive	28x28x1.4x0.4			

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- 3 Device Pinout
- 3.1 Pin Map
- 3.1.1 LQFP256

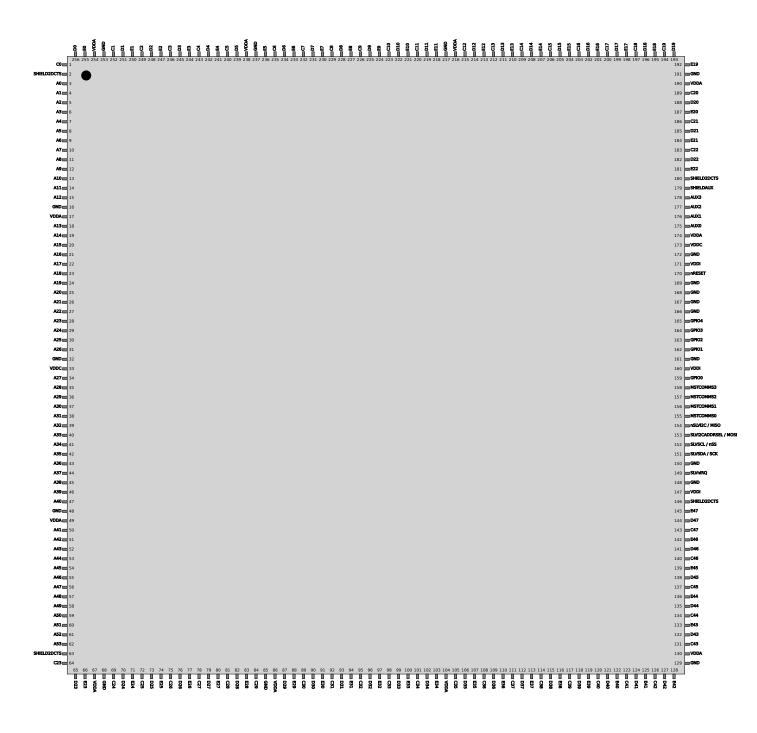


Figure 3.1.1-1: LQFP256 Device Pinout (top view)

3.2 Pin Table

3.2.1 LQFP256

Pin Number	Name	Class	Domain	Function	If not required	Notes
1	C0	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
2	SHIELD2DCTS A0	AO AIO	VDDA VDDA	2DCTS shield pin Sense pin	Not applicable Connect to SHIELD2DCTS	Shield driver for 2DCTS sense pins
4	AU Al	AIO	VDDA	Sense pin	Connect to SHIELD2DC15	
5	A1 A2	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
6	A3	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
7	A4	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
8	A5	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
9	A6	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
10	A7	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
11	A8	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
12	A9	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
13	A10	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
14	A11	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
15 16	A12 GND	AIO	VDDA	Sense pin Supply and signal reference	Connect to SHIELD2DCTS	
17	VDDA	PWR		Analogue supply	Not applicable Not applicable	
18	A13	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
19	A13 A14	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
20	A15	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
21	A16	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
22	A17	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
23	A18	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
24	A19	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
25	A20	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
26	A21	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
27	A22	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
28	A23	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
29	A24	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
30 31	A25	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
32	A26 GND	PWR	VDDA	Sense pin Supply and signal reference	Connect to SHIELD2DCTS Not applicable	
33	VDDC	PWR		Core supply	Not applicable	Output from internal LDO
34	A27	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
35	A28	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
36	A29	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
37	A30	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
38	A31	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
39	A32	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
40	A33	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
41	A34	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
42	A35	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
43	A36	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	Can be aliased to act as C48
44 45	A37 A38	AIO	VDDA VDDA	Sense pin	Connect to SHIELD2DCTS	Can be aliased to act as D48 Can be aliased to act as E48
45	A30 A39	AIO	VDDA	Sense pin Sense pin	Connect to SHIELD2DCTS Connect to SHIELD2DCTS	Can be aliased to act as C49
40	A37 A40	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	Can be aliased to act as D49
48	GND	PWR	VEBR	Supply and signal reference	Not applicable	
49	VDDA	PWR		Analogue supply	Not applicable	
50	A41	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	Can be aliased to act as E49
51	A42	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	Can be aliased to act as C50
52	A43	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	Can be aliased to act as D50
53	A44	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	Can be aliased to act as E50
54	A45	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	Can be aliased to act as C51
55	A46	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	Can be aliased to act as D51
56	A47	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	Can be aliased to act as E51
57	A48	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	Can be aliased to act as C52
58	A49	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	Can be aliased to act as D52
59 60	A50 A51	AIO	VDDA VDDA	Sense pin	Connect to SHIELD2DCTS Connect to SHIELD2DCTS	Can be aliased to act as E52 Can be aliased to act as C53
60	A51 A52	AIO	VDDA	Sense pin Sense pin	Connect to SHIELD2DCTS Connect to SHIELD2DCTS	Can be allased to act as C53 Can be allased to act as D53
62	A52 A53	AIO	VDDA	Sense pin	Connect to SHIELD2DC15	Can be aliased to act as E53
63	SHIELD2DCTS	AO	VDDA	2DCTS shield pin	Not applicable	Shield driver for 2DCTS sense pins
64	C23	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
65	D23	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
66	E23	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
67	VDDA	PWR		Analogue supply	Not applicable	
68	GND	PWR		Supply and signal reference	Not applicable	
69	C24	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
70	D24	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
71	E24	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
72	C25	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
73	D25	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
74 75	E25	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
	C26	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	

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Pin Number	Name	Class	Domain	Function	If not required	Notes
76	D26	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
77 78	E26	AIO	VDDA VDDA	Sense pin	Connect to SHIELD2DCTS Connect to SHIELD2DCTS	
78	C27 D27	AIO	VDDA	Sense pin Sense pin	Connect to SHIELD2DCTS	
80	E27	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
81	C28	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
82	D28	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
83	E28	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
84	C29	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
85	GND	PWR		Supply and signal reference	Not applicable	
86	VDDA	PWR		Analogue supply	Not applicable	
87	D29	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
88	E29	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
89	C30	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
90	D30	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
91 92	E30 C31	AIO	VDDA VDDA	Sense pin	Connect to SHIELD2DCTS	
92 93	D31	AIO	VDDA	Sense pin Sense pin	Connect to SHIELD2DCTS Connect to SHIELD2DCTS	
93	E31	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
95	C32	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
96	D32	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
97	E32	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
98	C33	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
99	D33	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
100	E33	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
101	C34	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
102	D34	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
103	E34	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
104	VDDA	PWR		Analogue supply	Not applicable	
105	C35	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
106	D35	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
107	E35	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
108	C36	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
109 110	D36	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS Connect to SHIELD2DCTS	
111	E36 C37	AIO	VDDA VDDA	Sense pin Sense pin	Connect to SHIELD2DCTS	
112	D37	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
113	E37	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
114	C38	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
115	D38	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
116	E38	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
117	C39	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
118	D39	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
119	E39	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
120	C40	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
121	D40	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
122	E40	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
123	C41	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
124 125	D41 E41	AIO	VDDA VDDA	Sense pin	Connect to SHIELD2DCTS Connect to SHIELD2DCTS	
125	C42	AIO	VDDA	Sense pin Sense pin	Connect to SHIELD2DCTS	
120	D42	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
127	E42	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
129	GND	PWR		Supply and signal reference	Not applicable	
130	VDDA	PWR		Analogue supply	Not applicable	
131	C43	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
132	D43	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
133	E43	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
134	C44	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
135	D44	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
136	E44	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
137	C45	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
138	D45	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS Connect to SHIELD2DCTS	
139 140	E45 C46	AIO	VDDA VDDA	Sense pin Sense pin	Connect to SHIELD2DCTS Connect to SHIELD2DCTS	
140	C40 D46	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
141	E46	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
142	C47	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
143	D47	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
145	E47	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
146	SHIELD2DCTS	AO	VDDA	2DCTS shield pin	Not applicable	Shield driver for 2DCTS sense pins
147	VDDI	PWR		I/O supply	Not applicable	
148	GND	PWR		Supply and signal reference	Not applicable	
149	SLVnIRQ	OD	VDDI	Slave report ready interrupt	Leave no connect	Requires additional pull up if used
150	GND	PWR		Supply and signal reference	Not applicable	

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Pin Number	Name	Class	Domain	Function	If not required	Notes
151	SLVSDA / SCK	ODwpu (may change to Iwpu during startup)	VDDI	Slave I2C data OR SPI SCK	Not applicable	Requires additional pull up if using I2C mode.
152	SLVSCL / nSS	ODwpu (may change to lwpu during startup)	VDDI	Slave I2C clock OR SPI nSS	Not applicable	Requires additional pull up if using I2C mode.
153	SLVI2CADDRSEL / MOSI	lwpu	VDDI	Slave I2C address select OR SPI MOSI	Not applicable	In I2C mode, controls address. In SPI mode becomes MOSI input from host
154	nSLVI2C / MISO	lwpu (may change to O during startup)	VDDI	Slave I2C mode OR SPI MISO	Not applicable	Sampled at reset; if low selects I2C mode, if high selects SPI mode and becomes MISO output to host
155	MSTCOMMS0	O/I/ ODwpu	VDDI	Master Comms port	Leave no connect	
156	MSTCOMMS1	O/I/ ODwpu	VDDI	Master Comms port	Leave no connect	
157	MSTCOMMS2	O/I/ Odwpu	VDDI	Master Comms port	Leave no connect	
158 159	MSTCOMMS3 GPIO0	O / I IOwpu	VDDI VDDI	Master Comms port General purpose I/O	Leave no connect Leave no connect	
160	VDDI	PWR	VBBI	I/O supply	Not applicable	
161 162	GND GPIO1	PWR	VDDI	Supply and signal reference General purpose I/O	Not applicable	Optionally serves as HSYNC input
162	GPIO1 GPIO2	IOwpu IOwpu	VDDI	General purpose I/O General purpose I/O	Leave no connect Leave no connect	Optionally serves as HSYNC Input Optionally serves as VSYNC/EXTSYNC input
164	GPIO3	lOwpu	VDDI	General purpose I/O	Leave no connect	
165 166	GPIO4 GND	IOwpu PWR	VDDI	General purpose I/O Supply and signal reference	Leave no connect Not applicable	
167	GND	PWR		Supply and signal reference	Not applicable	
168 169	GND GND	PWR PWR		Supply and signal reference Supply and signal reference	Not applicable Not applicable	
170	nRESET	Iwpu	VDDI	Hardware reset	Not applicable	May require additional bypass capacitor to GND for best
170	VDDI	PWR	VDDI	I/O supply	Not applicable	EMC
172	GND	PWR		Supply and signal reference	Not applicable	
173	VDDC	PWR		Core supply	Not applicable	Output from internal LDO
174 175	VDDA AUX0	PWR	VDDA	Analogue supply Auxiliarly sense pin	Not applicable Leave no connect	Sense pin for pressSense
176	AUX1	AIO	VDDA	Auxiliarly sense pin	Leave no connect	Sense pin for pressSense
177	AUX2	AIO	VDDA	Auxiliarly sense pin	Leave no connect	Sense pin for pressSense
178 179	AUX3 SHIELDAUX	AIO AO	VDDA VDDA	Auxiliarly sense pin Auxiliarly shield pin	Leave no connect Leave no connect	Sense pin for pressSense Shield driver for AUX sense pins
180	SHIELD2DCTS	AO	VDDA	2DCTS shield pin	Not applicable	Shield driver for 2DCTS sense pins
181 182	E22 D22	AIO	VDDA VDDA	Sense pin Sense pin	Connect to SHIELD2DCTS Connect to SHIELD2DCTS	
183	C22	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
184	E21	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
185 186	D21 C21	AIO	VDDA VDDA	Sense pin Sense pin	Connect to SHIELD2DCTS Connect to SHIELD2DCTS	
187	E20	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
188 189	D20 C20	AIO	VDDA VDDA	Sense pin Sense pin	Connect to SHIELD2DCTS Connect to SHIELD2DCTS	
190	VDDA	PWR	VUDA	Analogue supply	Not applicable	
191	GND	PWR		Supply and signal reference	Not applicable	
192 193	E19 D19	AIO	VDDA VDDA	Sense pin Sense pin	Connect to SHIELD2DCTS Connect to SHIELD2DCTS	
194	C19	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
195 196	E18 D18	AIO	VDDA VDDA	Sense pin Sense pin	Connect to SHIELD2DCTS Connect to SHIELD2DCTS	
197	C18	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
198 199	E17 D17	AIO AIO	VDDA VDDA	Sense pin Sense pin	Connect to SHIELD2DCTS Connect to SHIELD2DCTS	
200	C17	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
201	E16	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
202 203	D16 C16	AIO	VDDA VDDA	Sense pin Sense pin	Connect to SHIELD2DCTS Connect to SHIELD2DCTS	
204	E15	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
205 206	D15 C15	AIO	VDDA VDDA	Sense pin Sense pin	Connect to SHIELD2DCTS Connect to SHIELD2DCTS	
207	E14	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
208 209	D14 C14	AIO AIO	VDDA VDDA	Sense pin Sense pin	Connect to SHIELD2DCTS Connect to SHIELD2DCTS	
210	E13	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
211	D13	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
212 213	C13 E12	AIO AIO	VDDA VDDA	Sense pin Sense pin	Connect to SHIELD2DCTS Connect to SHIELD2DCTS	
214	D12	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
215 216	C12 VDDA	AIO	VDDA	Sense pin Analogue supply	Connect to SHIELD2DCTS Not applicable	
217	GND	PWR		Supply and signal reference	Not applicable	
218 219	E11 D11	AIO AIO	VDDA VDDA	Sense pin Sense pin	Connect to SHIELD2DCTS Connect to SHIELD2DCTS	
219	C11	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS Connect to SHIELD2DCTS	
221	E10	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
222 223	D10 C10	AIO	VDDA VDDA	Sense pin Sense pin	Connect to SHIELD2DCTS Connect to SHIELD2DCTS	
224	E9	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
225	D9	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	

Pin Number	Name	Class	Domain	Function	If not required	Notes
226	C9	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
227	E8	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
228	D8	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
229	C8	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
230	E7	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
231	D7	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
232	C7	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
233	E6	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
234	D6	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
235	C6	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
236	E5	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
237	GND	PWR		Supply and signal reference	Not applicable	
238	VDDA	PWR		Analogue supply	Not applicable	
239	D5	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
240	C5	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
241	E4	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
242	D4	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
243	C4	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
244	E3	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
245	D3	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
246	C3	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
247	E2	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
248	D2	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
249	C2	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
250	El	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
251	DI	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
252	C1	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
253	GND	PWR		Supply and signal reference	Not applicable	
254	VDDA	PWR		Analogue supply	Not applicable	
255	EO	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	
256	D0	AIO	VDDA	Sense pin	Connect to SHIELD2DCTS	

Table 3.2.1-1: LQFP256 Pin Table

Class	Description			
PWR	Power pin			
Al	Analogue input			
AO	Analogue output			
AIO	Analogue IO			
I	CMOS input (no pull up)			
lwpu	CMOS input with weak pull up ⁴			
0	CMOS push-pull output			
ODwpu	CMOS Open drain with weak pull up ⁴			
OD	CMOS Open drain no pull up			
IO	CMOS input/output			
lOwpu	CMOS input/output with weak pull up ⁴			

Table 3.2.1-2: Pin Classes

As a general convention, communication pin names are prefixed with "SLV" or "MST" to designate Slave or Master. Pin names with an "n" at the start of the function name designate an active-low signal e.g. MSTnIRQ is an active low interrupt from the Master. Also note that dual-mode pins are named (A) / (B), where (A) is the applicable name in the first mode and (B) in the second mode.

⁴Pull up/down intended as level keeper only.

4 Pin Descriptions

4.1 A0..53, C0..47, D0..47, E0..47

These are the sense pins, connected to the 2D CTS electrodes. The exact pin to electrode mapping is defined using the TouchHub configuration tool. The routing and layout of the connections to these pins is very important for best performance and is described in a separate application note. See **Appendix B References**.. Note that A36 through A53 can be configured to act as C48 D48 E48 through to C53 D53 E53 in support of ultra-wide aspect ratio sensor designs.

4.2 SHIELD2DCTS

The 2D CTS sense pins must be routed using a shielding technique using a dummy electrode that is driven by this pin. This is described in a separate application note. See **Appendix B References**. SHIELD2DCTS must be bypassed to GND near to the device, with a single 1nF 6V ceramic X5R (or tighter tolerance) capacitor.

4.3 GND

The OV power supply connection. Connect all GND pins to OV.

4.4 VDDA

The analogue sub-system's power supply connection, running at nominally 3.3V. Connect all VDDA pins to 3.3V. The VDDA supply must be low noise and well regulated. Each VDDA pin must have a parallel 22uF and 100nF ceramic capacitor within 2mm, bypassing to GND with a short low inductance PCB trace. An additional single bulk ceramic, tantalum or electrolytic capacitor of \geq 22uF is required on the VDDA supply. Under most conditions its is acceptable to share this supply with VDDI⁵.

These pins have special layout considerations. See Appendix A.1.1 Layout and Routing Considerations for VDDA tracks for further details.

4.5 VDDC

The core sub-system's power supply output, driven by an internal LDO running at nominally 1.8V. If there is more than one VDDC pin then connect them all together to form a single net. Each VDDC pin must have a parallel 22uF and 100nF ceramic capacitor within 2mm, bypassing to GND with a short low inductance PCB trace. No other connections to the VDDC net are permitted.

These pins have special layout considerations. See Appendix A.1.1 Layout and Routing Considerations for VDDA tracks for further details.

4.6 VDDI

The I/O sub-system's power supply connection, running at nominally 1.8V to 3.3V. Connect all VDDI pins to this supply. The VDDI supply is used to define the interface logic level used to communicate with the host. As such it must be sufficiently well regulated to ensure reliable high speed comms. Each VDDI pin must have a 100nF ceramic capacitor within 2mm, bypassing to GND with a short low inductance PCB trace. If the VDDA and VDDI supplies are separate then an additional single bulk ceramic, tantalum or electrolytic capacitor of ≥ 1 uF is required on the VDDI supply. Under most conditions it is OK to share this supply with VDDA in which case route VDDI as a separate net and use a star point connection to VDDA to help to isolate noise on the two domains⁵. CMOS I/O pins should never exceed the limitations stated in Table 10.1-1 (Vpc and Vpa) during power up, operation or power down.

These pins have special layout considerations. See Appendix A.1.1 Layout and Routing Considerations for VDDA tracks for further details.

⁵Assuming the I/O level is 3.3V

4.7 SLVnIRQ

The device generates an interrupt whenever it has a report waiting to be read by the host. The slave interrupt pin asserts low in this case. It returns to a Hi-Z state when no reports are pending (but is weakly pulled up). The action of the host reading a report is to consume that report, and when all reports have been consumed the pin returns to Hi-Z (wpu). In order to affect an acceptably fast low-to-high transition in the presence of parasitic capacitance, an external pull up of 1K to 10K is required. The host device should use *level* triggering to sense the interrupt.

4.8 SLVSDA / SCK

This pin serves different functions depending on the communication mode selected by the nSLVI2C pin:

Slave I2C Mode: The pin serves as the I2C Data pin to connect to the host. It has a weak internal pull up which must be supplemented with a 1K to 10K pull up to achieve correct rise and fall times depending on capacitive loading.

Slave SPI Mode: This pin becomes the SPI SCK clock input from the host. In this mode no additional pull-up resistor is required.

4.9 SLVSCL / nSS

This pin serves different functions depending on the communication mode selected by the nSLVI2C pin:

Slave I2C Mode: This pin is the I2C Clock pin to connect to the host. It has a weak internal pull up which must be supplemented with a 1K to 10K pull up to achieve correct rise and fall times depending on capacitive loading.

Slave SPI Mode: This pin becomes the SPI active low Slave Select input from the host. In this mode no additional pull-up resistor is required.

4.10 SLVI2CADDRSEL / MOSI

This pin serves different functions depending on the communication mode selected by the nSLVI2C pin:

Slave I2C Mode: Selects between 2 addresses for the device. See **7.3.1 Slave Address Selection** for details. The pin includes a weak pull up. It is strongly recommended to terminate this pin directly to GND or VDDI (as required) to completely override this pull up (but only when in Slave I2C mode!). **Slave SPI Mode:** The pin becomes the MOSI input from the host.

4.11 nSLVI2C / MISO

This pin serves different functions depending on its state as sampled at power-on or reset:

Sampled low at reset: Selects Slave I2C communications mode. The pin includes a weak pull up. It is strongly recommended to terminate this pin directly to GND to select Slave I2C mode.

Sampled high at reset: Selects Slave SPI communications mode. The pin includes a weak pull up. It is strongly recommended to use a supplemental pull-up of 1K to 10K to select SPI mode; the pin must not be terminated directly to VDDI ! On switching to SPI mode, the pin is changed to an output driver and is used as the MISO output to the host.

4.12 MSTCOMMS0

The device has a Master Communications port which can be controlled by a renderer in one of 3 modes: as a GPIO parallel output, as a master I2C interface or as a master SPI interface.

GPIO mode: this is the first output driver OUTA.

I2C mode: this is the Master I2C Data pin MSTSDA. It has a weak internal pull up which must be supplemented with a 1K to 10K pull up to achieve correct rise and fall times depending on capacitive loading.

SPI mode: this is the MOSI output data pin MSTMOSI to the slave.

4.13 MSTCOMMS1

The device has a Master Communications port which can be controlled by a renderer in one of 3 modes: as a GPIO parallel output, as a master I2C interface or as a master SPI interface.

GPIO mode: this is the second output driver OUTB.

I2C mode: this is the Master I2C Clock pin MSTSCL. It has a weak internal pull up which must be supplemented with a 1K to 10K pull up to achieve correct rise and fall times depending on capacitive loading.

SPI mode: this is the SCK clock output pin MSTSCK to the slave.

4.14 MSTCOMMS2

The device has a Master Communications port which can be controlled by a renderer in one of 3 modes: as a GPIO parallel output, as a master I2C interface or as a master SPI interface.

GPIO mode: this is the third output driver OUTC.

I2C mode: this is the active low interrupt pin MSTnIRQ. It has a weak internal pull up which may need to be supplemented depending on the nature of the driver connected to it. If the interrupt is shared between 2 or more devices then each must be capable of indicating via I2C commands whether it is actively asserting its interrupt or not.

SPI mode: this is the MISO input data pin MSTMISO from the slave.

4.15 MSTCOMMS3

The device has a Master Communications port which can be controlled by a renderer in one of 3 modes: as a GPIO parallel output, as a master I2C interface or as a master SPI interface.

GPIO mode: this is the forth output driver OUTD.

I2C mode: not used

SPI mode: this is the nSS active low slave select output pin MSTnSS to the slave.

4.16 GPIO0..4

General purpose I/O pins that can be configured and used by the host as required. Each one has an internal weak pull up included. Note the optional use of GPIO1 as an HSYNC input and GPIO2 as a VSYNC/EXTSYNC input (these optional selections are made via the device's configuration registers).

4.17 GND

Do not connect. This pin has an internal connection to the device and must not be connected externally.

4.18 nRESET

This pin is the asynchronus master hardware reset. Asserted low it returns the device to its reset state. When high, the device operates as normal. The pin has a weak internal pull up which must be supplemented with a 1K to 5K pull up and optionally a 20 to 50nF ceramic bypass capacitor to GND⁶ (to offer the best fast-transient immunity in harsh EMI applications).

4.19 AUX0..3

The auxiliary channels are used for pressSense. A single channel press system uses AUX0 only. A multi-channel press system uses all four channels. The routing and layout of the connections to these pins is critical and is described in a separate application note. See **Appendix B References**. There is also the need for a calibration capacitor for each used channel, connected between AUXn and SHIELDAUX.

4.20 SHIELDAUX

The auxiliary sense pins must be routed using a shielding technique using a dummy electrode that is driven by this pin. This is described in a separate application note. See **Appendix B References**.

⁶Check the ability of the connected reset driver to support this capacitive load

5 Reference Schematic

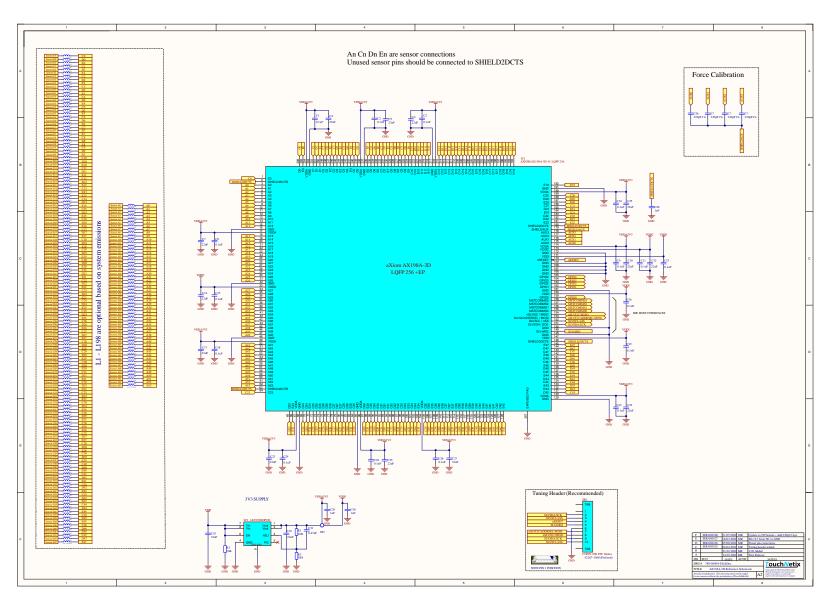


Figure 5-1: Reference Schematic (LQFP256)

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6 Sensing

6.1 Sensing Overview

The aXiom sensing architecture has been designed to measure capacitance, with a Signal-To-Noise ratio that goes far beyond existing solutions, whilst also being sympathetic to the diverse range of EMC and EMI challenges that are faced in real-world applications. Using a high purity narrow band drive waveform, with an amplitude of just 1.25V⁷, the controller not only has extremely low Radiated Emissions, but is also sympathetic to the long term sensor aging problem, that is seen when operating at elevated temperature and humidity. This little-documented aspect of touch sensors, can only be addressed by using low amplitude DC-neutral drive techniques, to radically slow-down the effects of electro-corrosion, electro-migration and e-field induced damage to various metals and some polymeric materials. To pass stringent EMC tests, in particular those dealing with injected currents (Conducted Immunity), many competing controllers resort to high sensor drive amplitudes to improve their overall SNR. While this may be successful in one regard, it seriously compromises both sensor lifetime and Radiated Emissions. Coupled with drive waveforms that are often square in nature (leading to complex harmonic content), it can be seen that a pure low amplitude drive signal is a major advantage in tough environments. To measure capacitance using small signals in the presence of large amounts external noise, requires that the sensing architecture and the analogue front end of the device, is carefully optimized to be able to recover the carrier, even when this is hundreds of times smaller than the interference; techniques that are well understood in modern radio systems but that are seldom used in touch sensing.

The device can be connected to a broad range of Capacitive Touch Sensor (CTS) styles, including both single and double connected versions of the well known *Diamond, Flooded* and *True Single Layer* types. To further extend the range of applications that are possible, the device treats its sensor pins as general resources and is able to use any pin as either drive or sense. This allows great flexibility in the aspect ratio of the CTS sensing area; the pool of sensor pins can be mapped to sensor electrodes in any ratio that is needed. This allows everything from long-thin touch areas to square touch areas to be created easily. The sensing architecture has more than enough dynamic range to handle the sensor measurement, in the presence of the diverse parasitics created by such extreme aspect ratios. This capability further extends to allowing direct support for truncated electrodes, often found in non-rectangular touch applications⁸.

The high SNR of the acquisition engine, allows a wide range of glove types and thicknesses to be used with the CTS. Alternatively, high quality multi-touch tracking through very thick plastic cover panels becomes possible; over 10mm of acrylic overlay can be used and can even have varying thickness, thanks to a novel compensation scheme that helps to unify the touch sensitivity across diverse thickness changes. Sensing through small air gaps also becomes viable⁹. Water suppression is built into the device's capability, allowing wet finger tracking and water rejection¹⁰.

⁷2.5V pk-pk

⁸Imagine a circular sensor; the outer electrodes have almost no surface area compared to those in the middle.

⁹Subject to mechanical stability considerations.

¹⁰Including saline solutions, blood etc with some sensing compromises.



The acquisition engine makes its measurements during a period called a Frame. Each frame is sub-divided into smaller time units called *Slots*. During a Frame, different measurement tasks (Slots) are scheduled. Typically, a Frame consists mainly of CTS and/or CDS Slots, simply because there are so many measurements to take. There are also typically, a small number of Slots used for housekeeping. To simplify things, TouchHub can automatically configure the Frame based on the system's requirements.

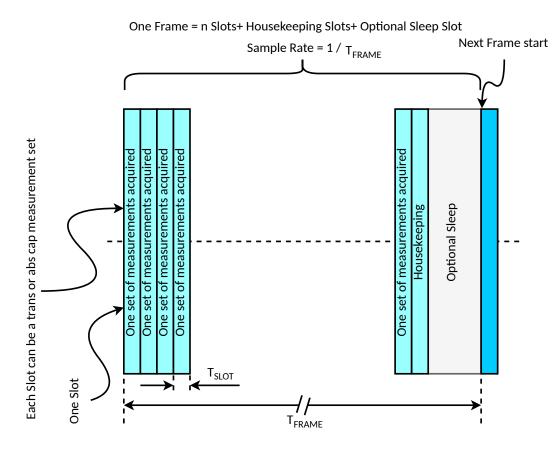


Figure 6.1-1: Acquisition Engine Frame Structure

The overall architecture of the AX198A-3D is shown below in simplified form.

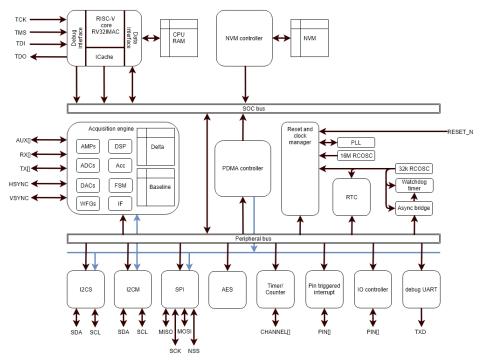


Figure 6.1-2: Simplified System Architecture

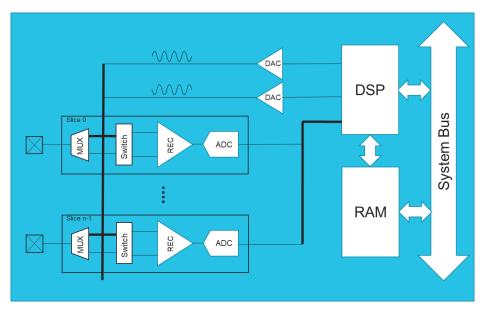


Figure 6.1-3: Simplified Sensing Architecture

6.2 Touch Sensing

6.2.1 2D (xy) Sensing

The AX198A-3D uses a *transverse capacitive* measurement technique ("trans-cap") to sense the capacitive coupling between pairs of electrodes. Traditionally, these would be called *transmitter* and *receiver* (or *drive* and *sense*) electrodes. The AX198A-3D sensing architecture is more flexible than existing devices, which makes it misleading to think of electrodes as having fixed transmit and receive functions. Rather, any electrode can be either function. Hence, we'll refer to them as either just electrodes or *sense pins* or even sometimes *channels*; the names are freely interchangeable.

The AX198A-3D has 198 sense pins. These can be wired to the electrodes of a 2D Capacitive Touch Sensor (2D CTS) in a very flexible way, enabling the creation of sensing areas with arbitrary aspect ratios. To simplify the design task, the supplied TouchHub2 software can take high-level design requirements, such as the number of electrodes in each axis of the CTS, and automatically decide which device pins to connect to which electrodes. For this reason, when you look in the Pin Description tables you will not see familiar names like "TX0" or "RX10". Instead, you will see pins with more generic names like "A0" and "D3". This way we reduce the risk of inferring the function of these pins. Likewise, we refer to the two axes as Rows and Columns rather than Tx and Rx.

The 2D CTS is typically formed of a grid of orthogonal electrodes. Where a Row and Column electrode intersect, a sensing node is formed. The capacitance of all nodes in the CTS are measured by the device once every *frame*¹¹. When a user touches the CTS, the node capacitances change near to the touch position and cause what is referred to as a *touch delta*. It is this touch delta that the device senses and converts into accurate touch positions.

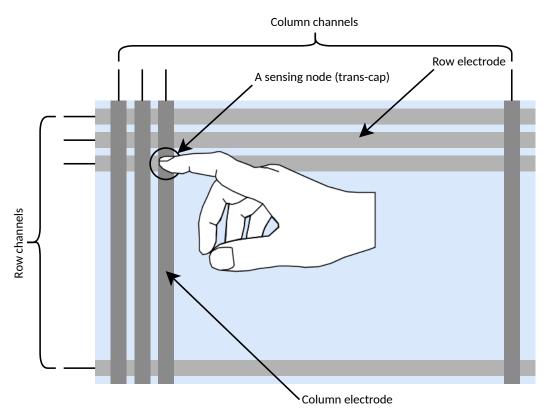


Figure 6.2.1-1: Channel Naming Convention

¹¹The measurement is conducted by the acquisition engine, which is instructed what to do by a configuration *profile* created by TouchHub2.

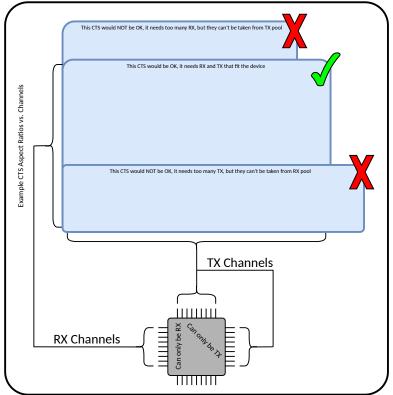
The AX198A-3D can measure up to 6144 nodes; this means that configurations where (RXs \times TXs \leq 6144) are supported. Some large, almost-square, designs may need to limit the number of RX and TX to stay within this limit. While any pin can be configured as either TX or RX, there are multiple factors which affect performance including how electrodes are assigned to pins. Therefore, it is necessary to use the TouchHub tool to determine the optimal connections to use for your sensor.

The AX198A-3D can report up to 10 concurrent touches, using advanced signal processing techniques to accurately resolve touch positions at up to 16 bits of resolution. To enhance the rate at which the host can read the status and position of these touches, all 10 touches are combined into a single compact report, reducing communication traffic and reducing the chance of the host missing important touch events.

aXiom AX198A-3D Datasheet







AXIOM CHANNEL ALLOCATION SCHEME: FREE CHOICE OF ASPECT RATIO

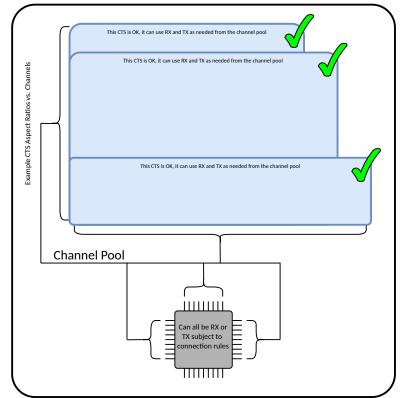


Figure 6.2.1-2: Traditional vs. aXiom Channel Allocation

6.2.2 1D (slider) and 0D (button) Sensing

As described above, the AX198A-3D has 198 channels. In many applications, some or all of these will be allocated to a 2D (xy) sensing grid of electrodes to resolve touch position above a display. However, the AX198A-3D has the ability to allocate arbitrary (albeit concurrent) ranges of channels, to be processed independently as though they were separate touch regions. A region can use any number of channels, from all available channels, which would of course result in a 2D region, right down to just one pair of channels¹² forming a 0D *button*. Up to 16 regions can be defined. Touch processing within regions works exactly like they are each a *sub 2D touch area*. This means that even a 0D button reports a touch event using the same reporting mechanism as a 2D region, sending its touch status and an xy position to the host. For a 0D region (1 x 1 channels), the xy position is fixed to report exactly mid-range (the host can hence ignore these coordinates). For a 1D region (1 x n channels), the xy position is fixed to mid-range in one axis and reports the touch position along the long axis.

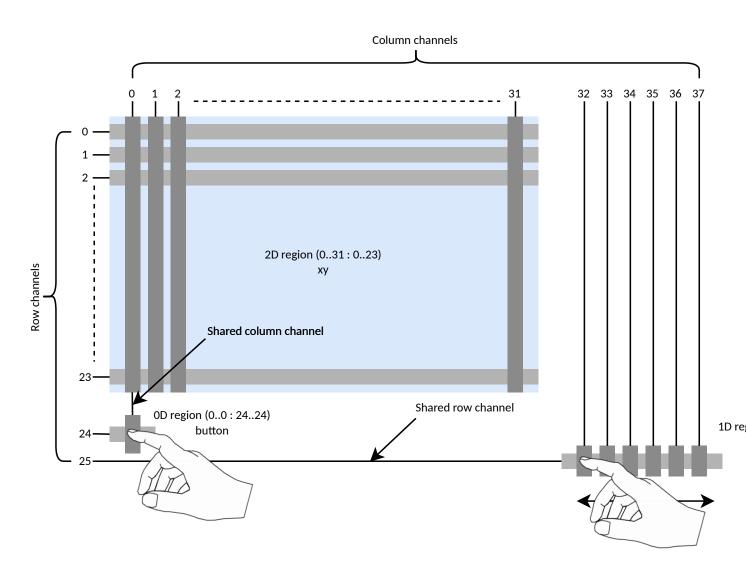


Figure 6.2.2-1: Region Types

¹²The smallest arrangement to allow for a trans-cap measurement of a single node.

The channels of the AX198A-3D are all measured using the same settings as part of the overall measurement frame. The allocation of the channels into regions is a post-measurement activity and as such, means that the electrical characteristics and environments of the physical sensing regions must be similar. For example, defining a 2D region of electrodes over a display, so adding significant load capacitance, will possibly require us to lower the measurement gain. This will also cause the same gain to be used for the channels allocated to a 0D button, hence the physical sensitivity of that button needs to be compatible with that gain. Note that the AX198A-3D has the ability to individually scale every node independently and that can help in such situations; see **6.3 Variable Thickness Lenses** for more information.

Region 0 is special, in that it can process 3D sensing events such as proximity and hover and is intended to be used with a 2D sensor (but it is not required to). All regions are identical in all other respects. Region reporting is done in the lower 2 bits of each of the 16-bit X and Y coordinates per-touch. This yields a combined 4-bit number i.e. 16 regions in total, with the touch coordinate using the remaining upper 14-bits of X and Y. If regions are not used the host can, if it chooses, simply process the coordinates as full 16-bit unsigned numbers and just ignore the fact that the lower 2-bits of each coordinate, are actually region identifier bits¹³. On the other hand, if regions are used, the host can still process the coordinates as 16-bit, but it can also isolate the combined 4-bit region identifier from X and Y, to tell which region a particular touch is in. This way the region reporting is conveniently embedded in with the normal report data.

Regions are also integrated with Haptic triggering, allowing different effects to be configured based on which region a touch is interacting with.

¹³The lower 2-bits are insignificantly small in a touch system and can be safely ignored anyway.

6.3 Variable Thickness Lenses

The AX198A-3D's acquisition engine includes a facility to scale the measured 2D touch delta array on a node-by-node basis. The scaling factors for each node can be changed using TouchHub via a configuration file. For most touch controllers, scaling the measured deltas in this way would simply amplify the background noise, to a point where it would cause excessive touch position jitter and even false detections. However, because the SNR of the AX198A-3D is so much higher, this amplification becomes viable, allowing corrections to the apparent gain of each and every node on the 2DCTS.

This delta scaling, opens up interesting new possibilities to support cover lenses with widely varying thickness across their surface. The scaling allows both attenuation and amplification, giving an adjustment range of x16 between areas requiring the lowest and highest gains. Additionally, any node can be completely suppressed, allowing regions of the sensor to be disabled. The rear side of the lens can remain flat, or perhaps curved in just 1 direction, making production lamination far easier than some schemes, that try to in-mold laminate the touch sensor into complex uniform thickness lenses.



Figure 6.3-1: Example of a Flat Sensor and Variable Thickness Lens

6.4 Dial On Display

The AX198A-3D has support for up to two Dial On Display mechanical rotors using its in-built rotational gesture engine, coupled with the ability to define special sensing regions within the main 2DCTS electrode grid. The device reports a relative angle (comparing to the initial detection point) from 0 to 359 degrees in steps of approximately one degree, and uses the same reporting mechanism as regular touches, hence making host support trivial. If desired, the special detection regions can be changed on-the-fly by the host, allowing Dials to be moved by the end user at run time¹⁴.

For further details see TNxAN00054 aXiom Touch Controller Dial On Display.

¹⁴The host needs to know where the Dial is, or at least when it has moved to one of a set of defined positions, and make appropriate configuration adjustments to the regions as required.

6.5 Force Sensing (Press Sense)

The AX198A-3D includes 4 AUX abs-cap channels, suitable for measuring the capacitive displacement sensor (CDS) used in press sensing systems (also known as force sensing). This style of sensor offers very high mechanical dynamic range, making it suitable for use in systems where alignment and stack tolerance would saturate other types of sensor. In order to harness this wide operating range, yet still measure the CDS with sufficient resolution¹⁵, the AX198A-3D uses up to 4 dedicated channels that are able to reduce the measurement burden caused by the large baseline capacitance of the CDS. Combined with the high SNR of the acquisition engine, press sensing systems can be designed that are virtually immune to wide manufacturing tolerances, yet can resolve displacements of microns.

Many press sensing systems require only a single channel to detect the overall displacement of a cover lens, relative to the system's chassis. This is a so-called *single press* system and is suitable for most applications; each touch contact is assigned the same pressure and hence, is suitable for User Interfaces where the predominant mode of operation *is single touch with pressure qualification*; multiple touch gestures are still supported but do not need any pressure element to function. On the other hand, using 4 channels allows the creation of a press sensing system that can approximate the pressure independently on 2 touches; a *multi-press* system. Mechanically, the setup is identical to a single-press system but the CDS is split into 4 quadrants, and each part is measured by one of the 4 AUX channels. When operating in this mode, the AX198A-3D can report an approximate press position i.e. the XY location where the center of pressure is calculated to be ¹⁶.

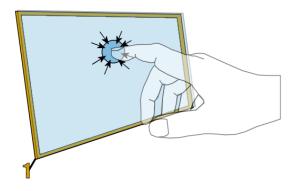


Figure 6.5-1: Single Press Sensing Connection, Non-segmented CDS

¹⁵...to resolve displacements of just a few micro-meters.

¹⁶Channel matching becomes more critical in this case and requires more attention to tolerances and offsets.

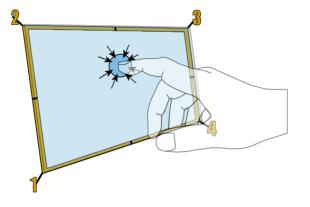


Figure 6.5-2: Four Press Sensing Connections, Quadrant-segmented CDS

The acquisition engine can be programmed to measure the CDS continuously, at the same time as it is performing its trans-cap measurements on the 2DCTS. Hence the measurement frame rate is identical to that of the touch system and time correlation of the 2 types of measurement is guaranteed by design.

The aXiom press sensing system, uses a patented CDS that has a very wide mechanical operating range and hence can absorb large assembly tolerance variation between production units, whilst maintaining excellent press sensitivity.

To ease production testing of systems equipped with press sensing, each connected AUX channel requires an accurate reference capacitor connected between it and SHIELDAUX. This allows precise and absolute measurement of the CDS's capacitance at run-time. This facility can be used as part of a design-time characterization/calibration of the mechanical displacement vs. the CDS's capacitance. Using this calibration table, the AX198A-3D can be used to estimate the mechanical gap of any assembled unit, to allow a production time check that it is within tolerance. It is important to stress that having such a wide operating window, coupled with the ability to check any unit's assembly tolerance, means that there is no need to individually calibrate each unit during production.

For further information on press sensing applications, see TNxAN00039 aXiom Touch Controller Press Sensing.

6.6 Pre-contact Sensing (3D Prox and Hover)

In order to sense a target before it makes physical contact with a capacitive touch sensor, it requires the ability to sense extremely small changes in capacitance. A *normal* contact target (a touch) will typically cause a change in trans-capacitance of 10's to 100's of Femto Farads (1fF = 10^{-15} F). A *pre-contact* target, on the other hand, will cause a change in capacitance that is closer to 100's of Atto Farads (1aF= 10^{-18} F). Clearly, high measurement SNR is key to being able to detect such targets.

Competing pre-contact solutions use extra sensing electrodes positioned around the outside edge of the 2DCTS. While this allows good detection range while hovering over, or close to the electrodes, the zone in the middle of the 2DCTS is far enough away to suffer a large drop in signal, making the center zone less sensitive¹⁷. The 2DCTS itself also acts as a heavy load on the extra electrodes, causing substantial parasitic capacitance on them, making the measurement system work even harder to detect small changes.

In contrast, the AX198A-3D can sense and report an approximate XY position for a pre-contact target without the use of additional electrodes. It can do this because it can achieve a hardware measurement SNR of over 80dB, or 1 part in 10000. When combined with firmware DSP techniques, it can sense a pre-contact target **above the 2DCTS** at a distance of over 100mm ("Prox") and start to resolve its XY position at over 50mm ("Hover"). This is achieved without needing extra sense electrodes, and hence no extra edge margin is consumed around the outside edge of the touch panel.

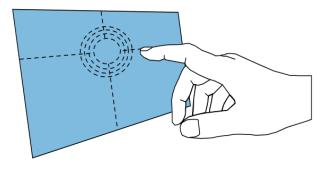


Figure 6.6-1: Sensing a Target Before Contact With The CTS

To further simplify the use of this feature, pre-contact targets are reported in exactly the same way as contact targets, but they have a flag to identify them as pre-contact together with a confidence factor, to give an indication of how far away (or weak) the pre-contact target is. This allows the host to qualify the use of the XY coordinates and take appropriate action based on the certainty of the report. Once a target makes contact with the 2DCTS, the AX198A-3D automatically reverts to a conventional touch mode, tags each detected target as a contact type and replaces the confidence factor with the force value detected from the CDS (if used) ¹⁸.

¹⁷Exactly the zone that requires the greatest sensitivity.

¹⁸The system can detect and report a single pre-contact target, or multiple contact targets but not both at the same time.

6.7 EMC Features

One of the toughest challenges faced by capacitive touch sensors, is that of achieving high electrical noise immunity to conducted interference. The reason is simple: in most typical electronic systems we only need to worry about noise on the power supplies relative to our own GND (0V), which is local to the system. Excess noise can always be filtered out. In a capacitive touch system, part of the sensing current travels via a capacitively coupled route, through the touching finger and back to the controller *via a 3rd terminal; earth.* So noise that is *common* to power *and* GND relative to earth, will appear in the capacitive measurement when, and only when, a touch is applied. In some compliance tests, this immunity aspect is checked by injecting a *common mode* signal and sweeping it from 150KHz to 80MHz, 80% amplitude modulated. This causes a voltage disturbance of nearly 50V peak-to-peak with respect to earth¹⁹! Noise of this type is encountered in many industrial, medical and automotive environments, caused by switch mode power supplies, inductive coupling between equipment cables etc. Clearly, because the noise is "earth referred" there is no obvious conventional way to filter it.

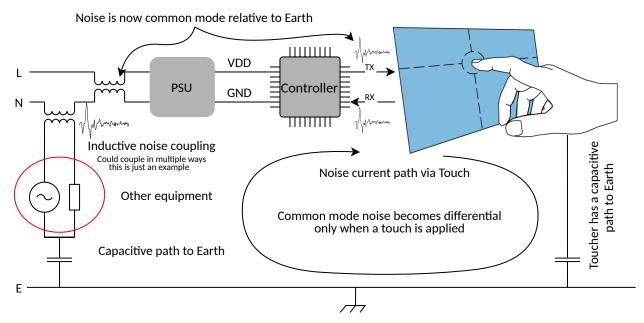


Figure 6.7-1: Example Common Mode Noise From "Other" Equipment

The nature²⁰ of a typical 2DCTS is that capacitance measurements at a frequency between 50 and 500KHz tend to be optimal. Clearly this frequency range overlaps the test band mentioned above; injecting noise at or near the measurement frequency will directly affect the measurement. In order to counter this, the AX198A-3D is frequency agile, being able to move its measurement frequency at will. This is known as *frequency hopping* and is a well understood method for avoiding interference in many aspects of electronics and radio communications²¹. The AX198A-3D uses a very narrow bandwidth to measure capacitance. This has the great advantage that in a congested spectrum with narrow quiet gaps, it is still possible to re-locate the acquisition frequency to affect low noise measurements. Many competing touch devices use an integration technique, employing an integrator with a sampled input. This gives rise to an extremely wide and complex reception spectrum²², making it hard to hop away from interference. A second advantage that narrow band demodulation offers, is that it is possible to very accurately measure the amount of external noise present at any moment; the AX198A-3D does this continuously each frame and hence it can react instantly if noise suddenly appears in the system. Competing systems can sometimes be fooled into thinking that there is zero noise, when certain noise frequencies are injected, and hence their measurements fail when no preventative steps are taken to frequency hop. The AX198A-3D can never be fooled in this way. The AX198A-3D also sets new standards in its ability to maintain several internal operating points, allowing it to hop quickly and seamlessly between frequencies.

²²the sampling window imposes a $\frac{sin(x)}{x}$ frequency response characteristic which is full of slowly reducing lobes and few, very narrow gaps to hop to.

¹⁹e.g. EN61000-4-6 Testing and measurement techniques - Immunity to conducted disturbances, induced by radio-frequency fields: Level 3.

²⁰i.e. its -3dB frequency response.

²¹Invented c. 1942 for guided torpedo anti-jamming.

To further protect the AX198A-3D against EMI, the signal path in the analogue front end, uses techniques to avoid its amplifiers from over-ranging in the presence of very high levels of interference. Even when such counter measures are employed, the touch report stability is still industry leading, thanks to the high SNR of the acquisition engine.

So far we have talked only about immunity to interference, but in some applications, emissions are just as big an issue. The AX198A-3D drives the CDS with a pure 1.25V amplitude sinusoidal waveform at a single frequency. Compare this to many competing devices that drive the sensor using a square wave at up to 30V peak-to-peak, leading to problems when trying to pass emissions certification.

6.8 Water Suppression

The AX198A-3D employs a unique architecture that allows it to make two types of measurement during the same frame: i) trans-cap (as already discussed) and ii) a second measurement type called *absolute capacitance* or *abs-cap*. Abs-cap measures the total capacitance of an electrode, rather than the coupling capacitance to another electrode. When abs-cap measurements are taken, they are done concurrently on a whole group of electrodes. This means that multiple electrodes are driven with near identical waveforms and hence the coupling capacitance from neighbour to neighbour is virtually neutralized; only the total capacitance of each electrode to GND+earth is sensed. This has the useful side-effect that water puddles, laying on the CTS lens surface that bridge between/across electrodes, become almost invisible from a capacitance point of view. Trans-cap measurements, on the other hand, will see normal touches and water puddles as almost identical. By making two types of measurement, the AX198A-3D can discriminate between such contacts and hence can offer a great improvement in *waterproofing* the overall touch solution.²³

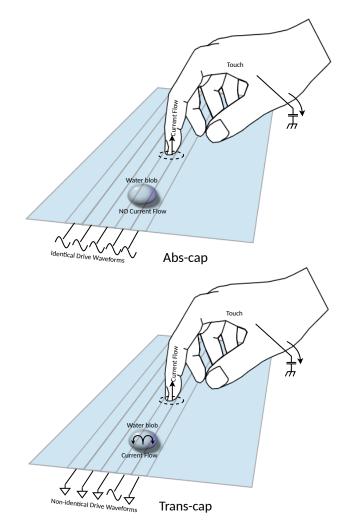


Figure 6.8-1: Different Behaviors With Abs-cap and Trans-cap Measurements With Water and Touch

²³These effects have been well known since the late 90's but implementation of dual measurement-mode controllers only became popular with the growth of mobile devices.

Abs-cap measurements come with their own set of challenges, mainly caused by the fact that the change in capacitance with touch, is a much smaller proportion of the electrode's *baseline capacitance* than it is with trans-cap²⁴. This leads to a requirement for even greater measurement SNR. There are ways to mitigate some of the extra capacitive loading on the electrodes, particularly those that live at the edges of the CTS, that would normally be exposed large areas of GNDed conductor (e.g. other traces, ESD rings etc). See **Appendix B References** for links to application notes that cover this topic in more detail.

During a frame, the AX198A-3D typically measures a 2DCTS in trans-cap mode across many sub-frame time slots (See **6.1 Sensing Overview**). Additionally, it will use multiple slots to measure the CTS in abs-cap mode. TouchHub software can create a configuration file that will schedule all of these measurements automatically.

²⁴i.e. the touch delta percent is smaller because the baseline capacitiance is so much higher (perhaps 10 to 100 times that of a trans-cap node).

6.9 Sensor Compatibility

The wide measurement range of aXiom devices means they can operate with most sensor styles and constructions. For further details refer to **TNxAN00042 aXiom Touch Controller Sensor Compatibility**.

6.10 Sensor Protection

Touch sensors are fabricated using a range of materials, some of which are extremely stable and some of which are not. Indium Tin Oxide (ITO), for example, commonly used to make the sensor's electrodes, is a ceramic conductor²⁵ that is remarkably robust to environmental damage caused by high temperature and humidity. It is very common to leave ITO exposed to the environment, even in harsh conditions²⁶. Other materials, notably the Silver commonly used to form the edge wiring on sensors, is a very different proposition when exposed to such conditions and when it is also supporting a voltage difference to a neighboring conductor. In these conditions, an effect known as Electro-Migration can occur over time, that forms small conductive "dendrites" between traces that eventually short circuit the touch sensor channels and cause premature failure. This is true for sensors that are fabricated on glass or plastic substrates. A common requirement in industrial and automotive environments, is to achieve a 504 hour operating life when exposed to 60°C and 90% relative humidity. This requirement sounds easy enough and indeed, many claim that their sensor / controller combination can pass this test. The reality is that the test is often conducted like a "storage" test with no power applied during the environmental exposure. This is not the same test! It is the application of power, and hence voltage, that causes the Electro-Migration. The rate of migration depends on many factors including the voltage differential between traces.

For this reason the AX198A-3D takes two special precautions:

- 1. It uses a very small drive amplitude of 1.25V (2.5V pk-pk) to measure the capacitance. Compare this to controllers that use 10 to 30V to drive the sensor.
- 2. It also biases all inactive electrodes in such a way that, all active drive voltages swing symmetrically either side of this bias; this has the effect of further slowing migration as the net DC level is approximately zero²⁷. Compare this to controllers that bias inactive electrodes to GND and drive with a pulsed 30V waveform.

Further discussion of these effects are beyond the scope of this document, but further information can be found in **Appendix B References**.

²⁵It can also be classed as an alloy depending on its exact composition.

²⁶Noting that standing water or other contaminants can etch ITO if they are acidic in nature.

²⁷Refered to as a DC neutral drive.

7 Host Interfaces

7.1 Available Interfaces

The AX198A-3D offers two ways to communicate with the host;

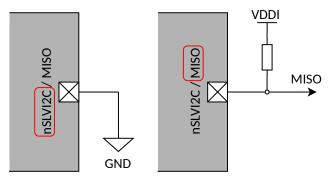
- A slave I2C interface consisting of the following pins (taking the name before the "/"): (SLVSDA / SCK), (SLVSCL / nSS) and an interrupt (SLVnIRQ). Rates up to 400KHz are supported
- A slave SPI interface consisting of the following pins (taking the name after the "/"): (SLVI2CADDRSEL / MOSI), (nSLVI2C / MISO), (SLVSDA / SCK), (SLVSCL / nSS) and an interrupt (SLVnIRQ). Rates up to 4MHz are supported

7.2 Mode Selection

A single pin controls which host interface is selected: **nSLVI2C / MISO**. The pin is sampled as the device starts up (from a power on, or reset event):

If the pin is sampled low, **Slave I2C** mode is selected If the pin is sampled high, **Slave SPI** mode is selected

The pin includes a weak pull-up that must be overridden either by tying it to GND (for I2C mode) or by **pulling up** with a supplemental resistor to VDDI (for SPI mode)²⁸ (see **4.11 nSLVI2C / MISO**)



Slave I2C Mode Slave SPI Mode Figure 7.2-1: Communication Mode Selection

²⁸In SPI mode the pin changes to become an output and hence must **not** be pulled up by tying directly to VDDI

7.3 Slave I2C Mode

7.3.1 Slave Address Selection

Two different Slave I2C addresses can be selected with the **SLVI2CADDRSEL / MOSI** pin. The pin is sampled as the device starts up (from a power-on, or reset event):

SLVI2CADDRSEL / MOSI level	Slave I2C Address (7-bit hex)
low	0х66
high	0x67

Table 7.3.1-1: Slave I2C Address Selection

See **4.10 SLVI2CADDRSEL / MOSI** for notes on terminating this pin.

7.3.2 Connections

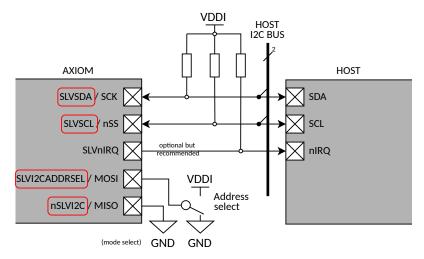


Figure 7.3.2-1: Slave I2C Connections

7.3.3 I2C Protocol

The communications protocol used to access configuration registers in the device and to receive event reports from the device, can be found in **TNxAN00035 aXiom Touch Controller Comms Protocol**. Real-time report collection from the device over the I2C interface has been optimized to work in an interrupt driven mode rather than being polled.

7.4 Slave SPI Mode

7.4.1 Device Selection

In order to communicate with the device the **SLVSCL / nSS** pin must be asserted low for (at least) the duration of the communication. It is OK to permanently connect **SLVSCL / nSS** to GND when in SPI mode, if the AX198A-3D is the only device on the SPI bus.

7.4.2 Connections

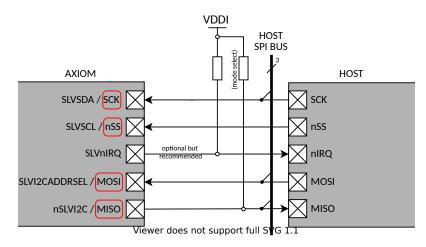


Figure 7.4.2-1: Slave SPI Connections

7.4.3 SPI Protocol

The SPI interface operates in Mode 0²⁹. The communications protocol used to access configuration registers in the device and to receive event reports from the device, can be found in **TNxAN00035 aXiom Touch Controller Comms Protocol**. Real-time report collection from the device over the SPI interface has been optimized to work in an interrupt driven mode rather than being polled.

²⁹Clock Polarity:0, Clock Phase:0, Clock Edge:1 (Clock idles at 0, and uses rising edge to sample data, and uses falling edge to shift data)

8 Haptics

In order to provide physical sensation feedback to a user who is touching and-or pressing on a surface, the AX198A-3D offers a mechanism to trigger a 3rd party Haptic driver device. To qualify when a Haptic effect should be played, the following events can be used to generate the overall trigger:

- Touch position.
- Touch movement.
- Applied force (rising).
- Applied force (falling).

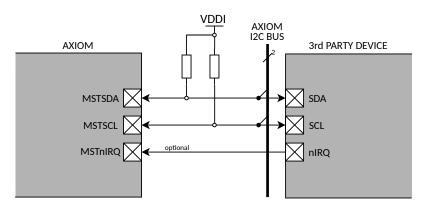


Figure 8-1: Master I²C Connections to 3rd Party Device(s)

The qualification by touch position is controlled using an array of configurable hot-spots over the 2D surface. Each hot-spot can be switched on and off efficiently, allowing the host to change UI screens (and selected hot-spots) smoothly. Hot-spot definition is sufficiently fine-grained to allow rectangular closed-form regions to be defined. Each hot-spot can be triggered based on a number of criteria and can also trigger a specific effect using the Master Comms interface. Additionally, hot-spots can be tagged in groups to allow their XY positions to be globally offset, allowing grouped hot-spots to be *scrolled* in synchronism with a UI.

aXiom can use the Master Comms port in one of 3 modes to trigger the playback of an effect:

- 1. In Master GPIO mode; driving a set of 4 output pins to control an actuator. (normally via an amplifier such as an H-Bridge driver).
- 2. In Master I²C mode³⁰; using the Master I²C interface to send commands to trigger a 3rd party actuator device.
- 3. In Master SPI mode³¹; using the Master SPI interface to send commands to trigger a 3rd party actuator device.

The first method is limited in that it only allows simple effects to be triggered. The second and third methods are much more flexible, as they can transmit a sequence of commands to a device that both define and trigger the effect. A typical example of such a 3^{rd} party actuator device is the Texas InstrumentsTM DRV2605. This can be connected to the Master Comms port I²C interface of the AX198A-3D and a series of I²C *macro* commands can be defined in the device configuration, to achieve various effects. As part of the I²C sequence, dynamic data can be sent to the device from the AX198A-3D such as X, Y, touch number, force value, effect etc.

For further details see TNxAN00036 aXiom Touch Controller Haptics Drive.

 $^{^{30}\}mbox{Noting that this is not related in any way to the Host Interface I^2C Mode.$

³¹Noting that this is not related in any way to the **Host** Interface SPI Mode.

9 Programming Model

aXiom devices use a register interface called *Touch Controller Protocol*, or TCP, which defines each and every register in the device, how they are organized and accessed. TCP covers configuration and tuning registers, as well as general status and information registers. For the transport of "live" data, TCP also describes a reporting scheme; this is particularly important for host device drivers, because it is the mechanism by which the device sends real-time touch information to the host.

While all aXiom devices use TCP, the exact set of registers and features offered by a specific device do vary. Hence, this general document does not present a detailed programming interface. Instead, you are directed to **TNxAN00060 aXiom AX198A Touch Controller Programmer's Guide**.

The runtime firmware in aXiom devices is field upgradable using a command and register interface called "Bootloader Protocol" or BLP, details of which can be found in **TNxAN00043 aXiom Touch Controller Bootloader**.

10 Device Characteristics

All quoted ranges are at an operating ambient temperature of 25°C unless otherwise stated.

10.1 Absolute Maximum Ratings

Stresses beyond those listed in Table 10.1-1 may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated in 10.2 Operational Ratings is not implied. Exposure to absolute maximum rated conditions for extended periods may affect device reliability.

Symbol	Parameter	Min	Max	Units
VDDA	Analogue supply	-0.3	4	V
VDDI	I/O supply	-0.3	4	V
V _{pc}	Voltage applied to any CMOS pin	-0.5	VDDI+0.5	V
I _{pc}	Maximum source/sink current for any CMOS pin	-25	25	mA
V _{pa}	Voltage applied to any Analogue pin	-0.5	VDDA+0.5	V
l _{pa}	Maximum source/sink current for any Analogue pin	-25	25	mA
T _S	Storage temperature (non operating)	-65	125	°C
TJ	Junction temperature (operating)		150	°C
ESD _{hbm}	ESD rating, human body model ³²		2000	V
ESD _{cdm}	ESD rating, charged device model ³²		750	V

Table 10.1-1: Absolute Maximum Ratings

³²Discharge direct to device pins. Discharge rating to the sensor/lens in a system is application specific but is typically far higher than this device rating.

10.2 Operational Ratings

10.2.1 Operating Conditions

Symbol	Parameter	Range	Units
T _A	Ambient temperature ³³	-40 to +105	°C
RH _A	Ambient relative humidity (non-condensing)	10 to 90	%RH

10.2.2 Power Requirements

Symbol	Parameter	Range ³⁴	Units
VDDA	Analogue supply	2.97 to 3.63	V
VDDI	I/O supply	1.62 to 3.63	V
IDDA	Active analogue supply current (average over frame)	TBD	mA
IDDI	I/O supply current (average over frame)	0.005 to 5	mA
N _{VDDA}	Allowable peak-to-peak noise and ripple on analogue supply	85mV	mV
N _{VDDI}	Allowable peak-to-peak noise and ripple on I/O supply	200mV	mV

Table 10.2.2-1: Power Requirements

Note that IDDA varies depending on the device's configuration, which defines the measurement types and durations that are performed. For host power supply sizing and thermal calculations, the maximum stated value should be used as an average with an allowance for +/-25% current variation away from the average during a measurement frame. The chosen regulator must be able cope with this transient current behaviour. Generally, a device configuration that employs only Trans Cap measurements will consume considerably less than one which also enables Abs Cap measurements that last for a significant percentage of the total frame time.

Also note that IDDI varies significantly depending on the amount of IO activity but is generally far smaller than IDDA. As noted in **4 Pin Descriptions** VDDA and VDDI are commonly shared and so this current should be added to the overall supply current budget.

10.2.3 Power Sequencing

There are no power sequencing requirements for the application or removal of (or between) VDDA and VDDI. Internal brown-out detection will prevent the device from operating until both VDDA and VDDC (internal) are properly established. VDDI is not level checked as it does not directly impact the internal operation of the device³⁵.

CMOS I/O pins should never exceed the limitations stated in Table 10.1-1 (Vpc and Vpa) during power up, operation or power down.

10.2.4 Startup Time

From the rising edge of **nRESET** (or when **VDDA** rises above approx. 2V) to the falling edge of **nIRQ**³⁶: < **110ms** typical. At this point the device is fully operational.

³³Subject to appropriate PCB design.

³⁴Treat these values as bounding limits

³⁵...but clearly VDDI needs to be correctly established in order to communicate with the device

³⁶The first interrupt is created by a "hello" System Manager report to the host



10.2.5 Reduced Power Mode

To conserve power during periods of low activity, the device can be configured to enter³⁷ a Reduced Power Mode (RPM). This trades off first detection latency (from RPM) against power consumption. Typical power reductions of 2 to 6x are possible as the RPM measurement rate is reduced. For further details refer to **TNxAN00061 aXiom Touch Controller Reduced Power Mode**.

³⁷Either automatically or by command)

10.2.6 CMOS I/O Characteristics

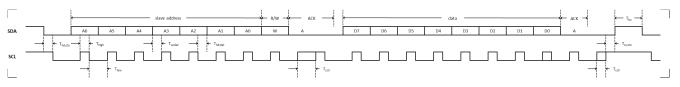
Symbol	Parameter	Range	Units
V _{IL}	Logic low input @ 3.3V VDDI	-0.3 to 0.8	V
V _{IH}	Logic high input @ 3.3V VDDI	2.0 to 3.6	V
V _{OL}	Logic low output @ 3.3V VDDI, 2mA sink	0.4 max	V
V _{OH}	Logic high output @ 3.3V VDDI, 2mA source	2.4 min	V
R _{WPU}	Weak pull up resistance @ 3.3V VDDI (where applicable)	3/1 //1	
V _{IL}	Logic low input @ 1.8V VDDI	-0.3 to 0.63	
V _{IH}	Logic high input @ 1.8V VDDI	1.2 to 3.6	V
V _{OL}	Logic low output @ 1.8V VDDI, 2mA sink	0.45 max	V
V _{OH}	Logic high output @ 1.8V VDDI, 2mA source 1.35 min		V
R _{WPU}	Weak pull up resistance @ 1.8V VDDI (where applicable)	69 - 201	Kohms
IIL	Input leakage current	±1 max	uA

Table 10.2.6-1: CMOS I/O Characteristics

10.2.7 Slave I2C Characteristics

The AX198A-3D implements a Slave I2C interface that is compliant with industry standards. It supports both Standard-mode (100KHz) and Fast-mode (400KHz). Addressing is 7-bit. Clock stretching support by the host *is* required.

Bus timings are as per **UM10204 I2C-bus specification and user manual Rev. 6 — 4 April 2014**. The general form of an I2C transaction is shown below. Additional I/O and timing parameters can be found in the aforementioned document in Table 9 and Table 10.





Symbol	Parameter	Min	Max	Units
T _{hd;sta}	Start bit hold time	600	-	ns
T _{high}	Clock high period	600	-	ns
Tlow	Clock low period	1300	-	ns
T _{su;dat}	Data setup time	100	-	ns
T _{hd;dat}	Data hold time	0	-	ns
T _{cstr}	Maximum clock stretch by slave	-	5	US
T _{su;sto}	Stop bit setup time	600	-	ns
T _{bu}	Bus free time between stop and start	1300	-	ns

Table 10.2.7-1: Timings

10.2.8 Slave SPI Characteristics

The AX198A-3D implements a Slave SPI interface that is compliant with industry standards. It supports Mode 0 communication at up to 4MHz. The most significant bits of 8-bit data fields are exchanged first.

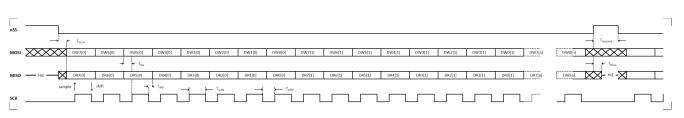


Figure 10.2.8-1: Typical SPI Transaction and Parameters

Symbol	Parameter	Min	Max	Units
T _{hiz;ss}	nSS transition to MISO transition to/from HiZ	-	20	ns
T _{dsu}	Data setup time (MOSI to SCK)	20	-	ns
T _{dhd}	Data hold time (SCK to MISO)	50	-	ns
T _{sckhi}	SCK high period ³⁸	100	-	ns
T _{scklo}	SCK low period ³⁹	100	-	ns
Trecovery	Slave recovery time, ready for next transfer ⁴⁰	-	45	US

Table 10.2.8-1: Timings

³⁸Subject to maximum SCK frequency of 4MHz.

³⁹Subject to maximum SCK frequency of 4MHz.

⁴⁰The host must ensure that it does not violate this recovery time by ensuring that transfers are spaced apart sufficiently to let the slave prepare for the next transfer. Violating this timing will result in undefined Slave behaviour, possibly lasting beyond the initial violated transfer.



10.2.9 Master I2C Characteristics

The Master I2C interface implemented in the AX198A-3D is intended for communication with one or more 3rd party slave devices. The characteristics of the interface are identical to those of the Slave I2C interface. See **10.2.7 Slave I2C Characteristics** for details. The Master I2C interface supports clock stretching by a connected slave.

10.2.10 Capacitance Ranges and Drive Limits

Symbol	Parameter	Absolute min	Recommended min	Recommended max	Absolute max	Units
F _{EXC}	Excitation frequency	30	50	250	500	KHz
V _{EXC} -trans	Trans Cap excitation voltage		2.5	2.5	VDDA-0.6	V
V _{EXC-ABS}	Abs cap excitation voltage pk-to-pk (centered around VDDA/2)	0	2.4	2.4	VDDA-0.9	V
C _{SHIELD2DCTS}	Total capacitance to GND on SHIELD2DCTS	-	-	-	20	nF
C _{SHIELDAUX}	Total capacitance to GND on SHIELDAUX		-	-	20	nF
C _{ABCD} -TRANS	Total Trans Capacitance load on only A, C, D or E pin	0.5	1.25	2.5	5	рF
C _{ABCD-ABS}	Total Abs Capacitance to GND on only A, C, D or E pin	20	-	200	500	рF
C _{AUX-ABS}	Total Abs Capacitance to GND on only AUX pin	20	-	-	1000	рF

Table 10.2.10-1: Capacitance Ranges and Drive Limits

Note that F_{EXC} , $V_{EXC-TRANS}$, $V_{EXC-ABS}$ can be directly controlled via the device's configuration registers so ensuring that the limits are met by tuning. The capacitance limits relate to external factors arising from the attached sensor and associated tracking.

Symbo	Parameter	Value	Tolerance	Dielectric	Units
C _{CALCA}	CALCAP reference capacitors	220	1%	NP0 / COG	pF

Table 10.2.10-2: CALCAP Requirements

10.2.11 Non-volatile Memory Characteristics

Symbol	Parameter	Range	Units
N _{EC}	Number of erase cycles	10000	cycles
t _{DR}	Data retention @ 85°C T _A	10	years
EDAC	Error detection and correction	Detect and correct all 1-bit errors Detect all 2-bit errors	-

Table 10.2.11-1: Non-volatile Memory Characteristics

10.2.12 Device BIST Capabilities

- RAM self tests
- NVM EDAC (see 10.2.11 Non-volatile Memory Characteristics)
- Code execution protection using Watchdog Timer clocked by separate internal oscillator
- Checksum over NVM
- Checksum over volatile configuration
- Checksum over non-volatile configuration
- Out of range VDDA detection
- Out of range Acquistion Engine reference capacitor checks
- Interrupt pin test
- Cross-check main CPU and RTC/watchdog oscillators against each other
- Configurable "Heartbeat" report to host allows BIST trigger (limited range) and live status plus a cross check of the timing period/CPU main oscillator rate

10.2.13 Sensor BIST Capabilities

- All sense channels allow detection of CTS and CDS impedance leakage of up to 200K Ω to any net – Test can be triggered by host command and optionally run at device boot-up
- Detection of opens on CTS and CDS electrode channel by configurable signal limits
 Test can be triggered by host command and also run periodically using Heartbeat tick
- Separate signal limit tests for Trans Cap, Abs Cap and AUX
- Separate test limits for the middle, edges and corners of a CTS (Trans Cap mode) to improve fault coverage

<u>TouchNeti</u>x



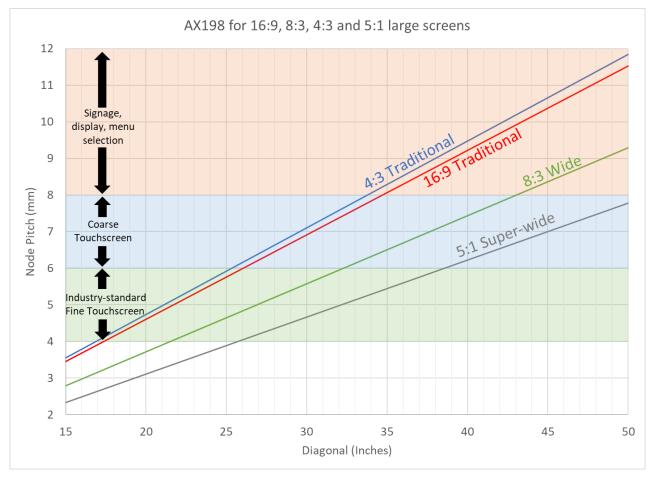


Figure 10.2.14-1: 2D CTS Diagonal Size Range Guide

Appendix A Package Drawings

A.1 LQFP256-EP28281404

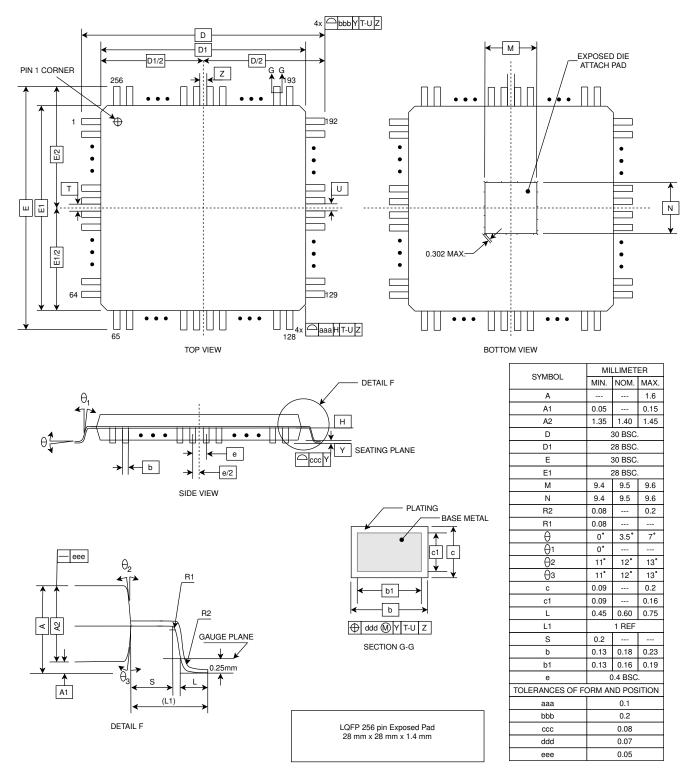


Figure A.1-1: LQFP256 Exposed Pad 28x28x1.4x0.4 Package Drawing

A.1.1 Layout and Routing Considerations for VDDA tracks

To maximize SNR performance special care must be taken when laying out VDDA power traces.

The maximum tolerated voltage drop *between* VDDA pins varies. The table below should be used for estimation of device current consumption into each VDDA pin to allow estimation of the voltage drops in your PCB layout (the IR voltage drop). You must then check that they are within the allowed range as listed below.

Pin	Туре	Max Current (mA)	ΔV
17	VDDA	25	
49	VDDA	25	
67	VDDA	50	
86	VDDA	25	
104	VDDA	50	<0.5mV Δ V between these pins
130	VDDA	25	
190	VDDA	25	
216	VDDA	50	
238	VDDA	25	
254	VDDA	50	
174	VDDA	300	<5mV Δ V from other VDDA power pins

In addition, the device has two VDDC pins, the following shall be observed.

Pin	Туре	Max Current (mA)	ΔV
33	VDDC	150	<10mV Δ V between these two pins
173	VDDC	150	

The images provided are for general guidance. Gerber files for reference designs can be provided by TouchNetix on demand.

Please note: any reference material provided shall be taken as guidance only. PCB designers must ensure to run power/current analysis on their designs to make sure they are compliant with the requirements outlined above.

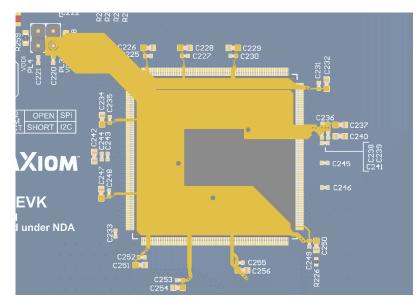


Figure A.1.1-1: C-shaped power routing, balanced amongst all VDDA pins.

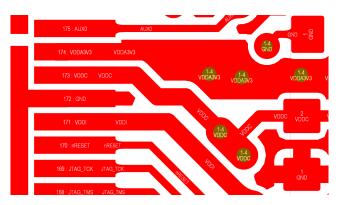
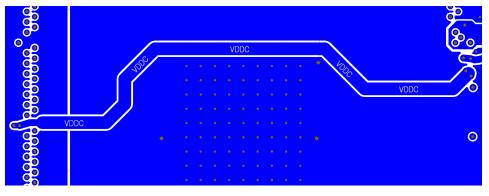
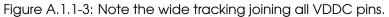


Figure A.1.1-2: Note the use of the widest possible tracking and multiple vias for all VDD tracks.





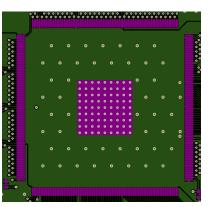
A.1.2 Package Thermal Characteristics

 $\theta_{\rm JA}$ (junction to ambient ⁴¹) : 16°C/W

A.1.3 PCB Footprint Notes

The LQFP256 package has an exposed center GND pad that must be soldered and via'd to suitable copper regions on a 4-layer PCB to help improve the thermal conductivity from junction to ambient. Follow these rules to achieve the stated thermal performance:

1. Use a center GND PCB pad (to connect to device's exposed pad) which is 10mm x 10mm, using a solder paste stencil that is cross hatched (e.g. 1.5mm square pads) to avoid excessive solder



2. The center pad must have a minimum of 81 off, 0.3mm diameter, plugged⁴² vias connecting to GND floods on the layers below

3. Signal traces should not be routed under the device body to allow maximal copper flood under the device body without adding capacitive burden to the driven shield signals⁴³

4. Where possible use 2oz copper (finished) on the PCB outer layers to improve heat flow

5. Use a GND flood that extends on each layer up to the device pins, under the entire device body area (noting that power trace(s) will likely need to bisect the flood on one inner layer)

6. Use extra 0.3mm regular or plugged vias placed on a 1.5mm pitch to "stitch" the GND floods together electrically and thermally under the device

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7. Extend a copper GND flood from underneath the body, past the non-sensing pins (i.e. predominantly on one package edge) on the bottom layer of the PCB to create an extra area of at least 25mm x 25mm. Keep this area wide and continuous and avoid adding narrow necks or meanders so that the area functions as a good thermal conductor away from the device

8. If uncertain, please contact TNx

The above rules assume a 4-layer (minimum) PCB and that the design goal is to meet 105°C ambient temperature operation. In situations where a lower operating temperature is required (e.g. Industrial/Medical) these rules can be relaxed to a 2-layer PCB but special care should be taken to optimize the outer layer copper floods on the rear side to allow enough heat to flow away from the device.

⁴¹When soldered to PCB as described in A.1.3 PCB Footprint Notes

⁴²To avoid solder wicking from under the body during reflow

⁴³maximum added capacitance to the SHIELD2DCTS or SHIELDAUX nets must not be greater than 100pF

Appendix B References

TNxAN00035 aXiom Touch Controller Comms Protocol. TNxAN00036 aXiom Touch Controller Haptics Drive. TNxAN00037 aXiom Touch Controller Sensor Channel Routing. TNxAN00039 aXiom Touch Controller Press Sensing. TNxAN00041 aXiom Touch Controller 3D Prox and Hover. TNxAN00042 aXiom Touch Controller Sensor Compatibility. TNxAN00043 aXiom Touch Controller Bootloader. TNxAN00071 aXiom Touch Controller AX198A EVK Quick Start Guide. TNxAN00045 aXiom Touch Controller Comms Quick Start Guide. TNxAN00046 aXiom Touch Controller Multi Press Demo Guide. TNxAN00047 aXiom Touch Controller Sensor Testing. TNxAN00048 aXiom Touch Controller EMC Report. TNxAN00051 aXiom Driver Guide. TNxAN00052 aXiom Project Flow. TNxAN00053 aXiom Touch Controller 3D Gestures. TNxAN00054 aXiom Touch Controller Dial On Display. TNxAN00055 aXiom Dial On Display Quick Start. TNxAN00056 aXiom Self Test. TNxAN00059 aXiom Auto Tune. TNxAN00061 aXiom Touch Controller Reduced Power Mode. TNxAN00062 aXiom 3D HID Digitizer Support. TNxAN00063 TouchHub2 Setup Guide. TNxAN00066 aXiom Tuning Guide. TNxAN00067 aXiom Production Test Development Guide. TNxAN00069 aXiom AUX Temperature Compensation. TNxAN00070 TouchNetix Sensor Designer for aXiom Users Guide. TNxAN00060 aXiom AX198A Touch Controller Programmer's Guide.

Release of the above documents may require execution of a specific NDA.

Appendix C Legal Copyright and Disclaimer

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Revision	Date	Change summary
A1	13/01/2021	Preliminary release
A2	15/02/2021	Add notes about Reduced Power Mode, shipping tray details
A3	06/04/2021	Add tuning header in ref schematic
A4	23/04/2021	Full document release
A5	09/06/2021	Correct pin 171,172,253,254 designations in the pin table (no change to pin map or device). Add note about max nodes. Add sensing architecture diagram
A6	06/08/2021	Correct ref schematic pin out
A7	19/11/2021	Add power requirements detail and update thermal PCB layout details. Formatting clean ups
A8	28/02/2022	Updated ordering information. Corrected pin name on Fig, 3.1.1-1 from SLVSCK to SLVSCL.
A9	10/03/2022	Added VDDA layout considerations. Changed Pin 167 from NC to GND.
B1	12/06/2022	Rename to 3D variant. Include AUXn reference caps.
B2	19/08/2022	Add more details for reference / cal caps.

Appendix D Document History